

## Dual N-Channel 30 V (D-S) MOSFET

PRODUC	CT SUMMARY		
V <sub>DS</sub> (V)	$R_{DS(on)}$ ( $\Omega$ )	I <sub>D</sub> (A)	Q <sub>g</sub> (Typ.)
30	$0.009  \text{at V}_{\text{GS}} = 10  \text{V}$	35	15 nC
30	$0.016$ at $V_{GS} = 4.5 \text{ V}$	30	15 110

#### **FEATURES**

- Halogen-free According to IEC 61249-2-21 Definition
- TrenchFET® Power MOSFET
- 100 % UIS Tested
- 100 % R<sub>q</sub> Tested
- Compliant to RoHS Directive 2002/95/EC

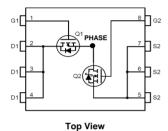


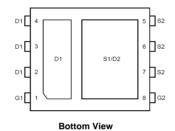
HALOGEN FREE

#### **DFN 3\*3**

### **APPLICATIONS** · Set Top Box







ABSOLUTE MAXIMUM RATIN	IGS T <sub>A</sub> = 25 °C,	unless othe	erwise noted		
Parameter Drain-Source Voltage		Symbol	Limit	Unit	
		$V_{DS}$	30	V	
Gate-Source Voltage		$V_{GS}$	± 20	V	
	T <sub>C</sub> = 25 °C		35 <sup>a</sup>		
Continuous Drain Current (T <sub>J</sub> = 150 °C)	$T_C = 70 ^{\circ}\text{C}$ $T_A = 25 ^{\circ}\text{C}$	I <sub>D</sub>	24 17.5 <sup>b, c</sup>		
	T <sub>A</sub> = 70 °C		15.5b, c	Α Α	
Pulsed Drain Current		I <sub>DM</sub>	105		
Continuous Source-Drain Diode Current	T <sub>C</sub> = 25 °C	I <sub>S</sub>	2.25		
	T <sub>A</sub> = 25 °C	J	1.48 <sup>b, c</sup>		
Single Pulse Avalanche Current  L = 0.1 mH		I <sub>AS</sub>	5		
Single Pulse Avalanche Energy		E <sub>AS</sub>	1.25	mJ	
	T <sub>C</sub> = 25 °C		56		
Maximum Power Dissipation	T <sub>C</sub> = 70 °C	P <sub>D</sub>	15	W	
Maximum I Ower Dissipation	T <sub>A</sub> = 25 °C	. D	2.18 <sup>b, c</sup>		
	$T_A = 70  ^{\circ}C$		1.34 <sup>b, c</sup>		
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	- 55 to 150	°C	

THERMAL RESISTANCE RA	TINGS					
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient <sup>a, c, d</sup>	t ≤ 10 s	R <sub>thJA</sub>	58	70	°C/W	
Maximum Junction-to-Foot (Drain)	Steady State	R <sub>th IE</sub>	38	45	C/VV	

#### Notes:

- a. Package limited, T<sub>C</sub> = 25 °C.
  b. Surface Mounted on 1" x 1" FR4 board.
- d. Maximum under Steady State conditions is 110 °C/W.



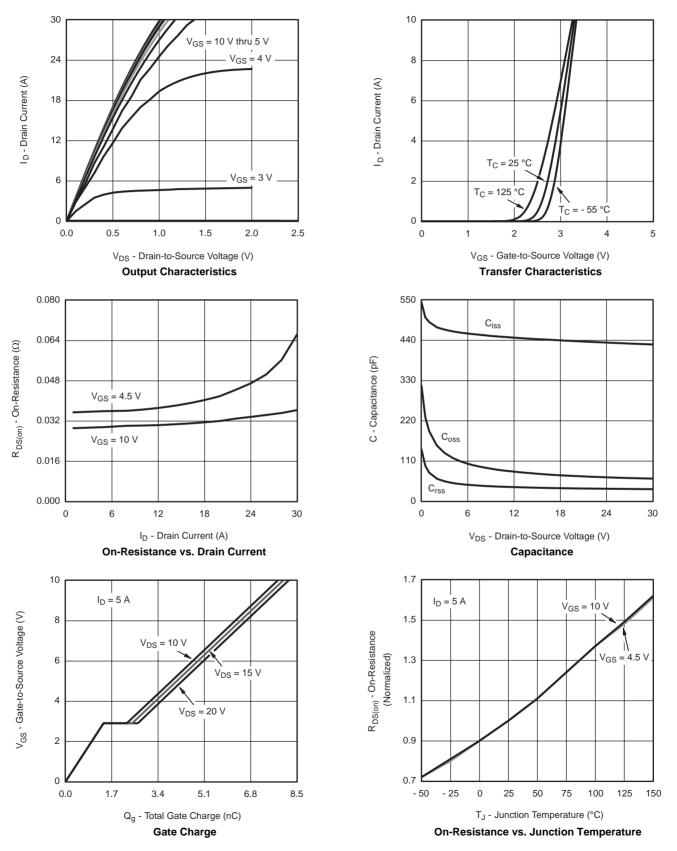
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Static			•		•	•
Drain-Source Breakdown Voltage	$V_{DS}$	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	30			V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	1 - 250 uA		32		
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	$I_{D} = 250  \mu A$		- 5.0		mV/°0
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}$ , $I_{D} = 250  \mu A$	1.0		2.5	V
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA
	1 . 1	$V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}$			1	
Zero Gate Voltage Drain Current	IDSS	V <sub>DS</sub> = 30 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 55 °C			10	μΑ
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	V <sub>DS</sub> ≥ 5 V, V <sub>GS</sub> = 10 V	10			Α
	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 5 A			0.009		
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	$V_{GS} = 4.5 \text{ V, } I_{D} = 4 \text{ A}$		0.016		Ω
Forward Transconductance <sup>a</sup>	g <sub>fs</sub>	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 5 A		16		S
Dynamic <sup>b</sup>		-		L		
Input Capacitance	C <sub>iss</sub>			900		
Output Capacitance	C <sub>oss</sub>	$V_{DS} = 15 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		257		pF
Reverse Transfer Capacitance	C <sub>rss</sub>			155		
		$V_{DS} = 15 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 5 \text{ A}$		15		
Total Gate Charge	$Q_g$			3.7 5.6		
Gate-Source Charge	Q <sub>gs</sub>	$V_{DS} = 15 \text{ V}, V_{GS} = 4.5 \text{ V}, I_{D} = 5 \text{ A}$		1.4		nC
Gate-Drain Charge	$Q_{gd}$			1.05		
Gate Resistance	R <sub>g</sub>	f = 1 MHz	0.8	4.3	8.6	Ω
Turn-On Delay Time	t <sub>d(on)</sub>			12	24	
Rise Time	t <sub>r</sub>	$V_{DD}$ = 15 V, $R_L$ = 3 $\Omega$		55	100	
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong 5 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_g = 1 \Omega$		11	22	
Fall Time	t <sub>f</sub>			8	16	
Turn-On Delay Time	t <sub>d(on)</sub>			4	8	ns
Rise Time	t <sub>r</sub>	$V_{DD} = 15 \text{ V}, R_L = 3 \Omega$		9	18	
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong 5 \text{ A}, V_{GEN} = 10 \text{ V}, R_g = 1 \Omega$		10	20	
Fall Time	t <sub>f</sub>			6	12	
<b>Drain-Source Body Diode Characteristi</b>	cs		l	L	l	l
Continuous Source-Drain Diode Current	I <sub>S</sub>	T <sub>C</sub> = 25 °C		35		
Pulse Diode Forward Current	I <sub>SM</sub>				105	A
Body Diode Voltage	$V_{SD}$	I <sub>S</sub> = 2 A, V <sub>GS</sub> = 0 V		0.8	1.2	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>			11	20	ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	L EA di/d+ 400 A/::- T 05 00		4	8	nC
Reverse Recovery Fall Time	ta	$I_F = 5 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, T_J = 25 ^{\circ}\text{C}$		7		
Reverse Recovery Rise Time	t <sub>b</sub>			4		ns

#### Notes:

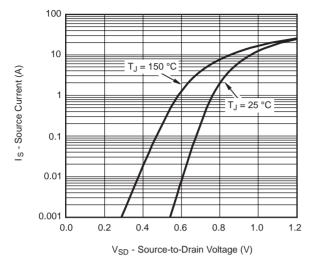
- a. Pulse test; pulse width  $\leq 300~\mu s,~duty~cycle \leq 2~\%$
- b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

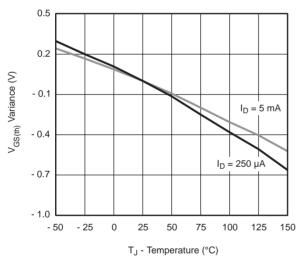




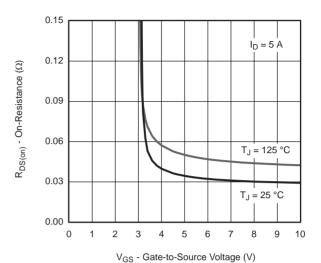




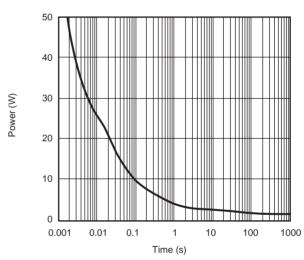
#### Source-Drain Diode Forward Voltage



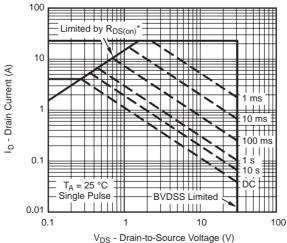
#### **Threshold Voltage**



On-Resistance vs. Gate-to-Source Voltage



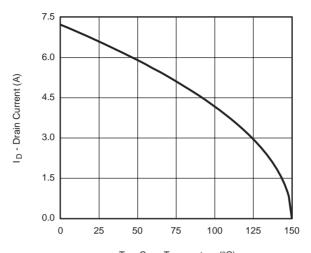
Single Pulse Power



\* V<sub>GS</sub> > minimum V<sub>GS</sub> at which R<sub>DS(on)</sub> is specified

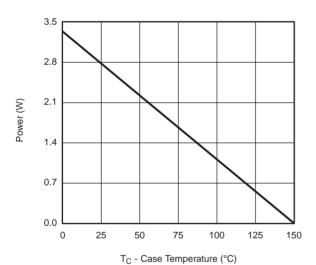
 $^*$   $V_{GS}$  > minimum  $V_{GS}$  at which  $R_{DS(on)}$  is specified Safe Operating Area, Junction-to-Ambient



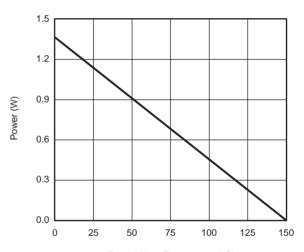


T<sub>C</sub> - Case Temperature (°C)

#### **Current Derating\***



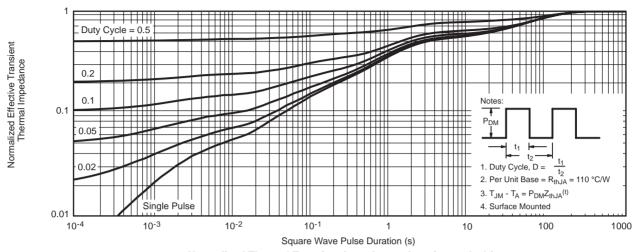
Power, Junction-to-Foot



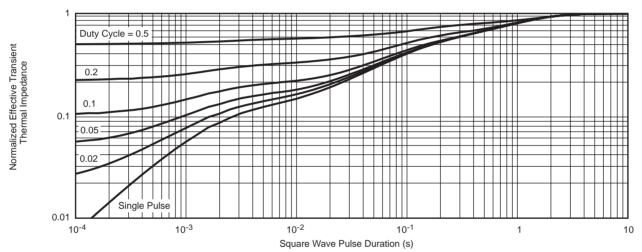
T<sub>A</sub> - Ambient Temperature (°C) **Power, Junction-to-Ambient** 

<sup>\*</sup> The power dissipation  $P_D$  is based on  $T_{J(max)} = 150$  °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





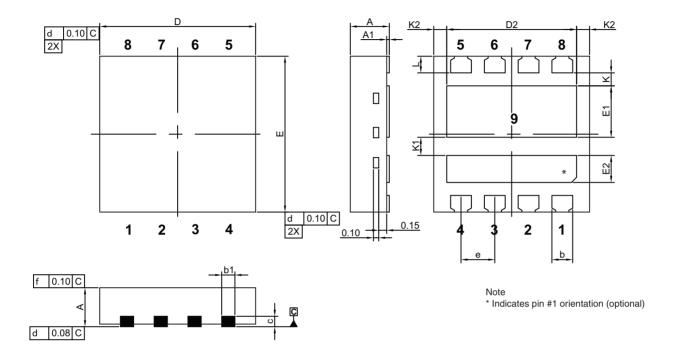
Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Foot



## PowerPAIR® 3 x 3 Case Outline

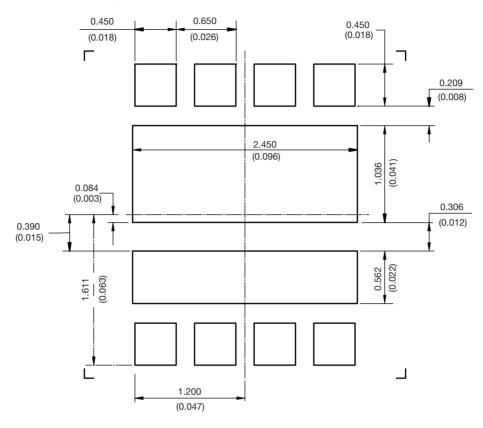


	MILLIMETERS			INCHES				
DIM.	MIN.	NOM.	MAX.	MIN.	NOM.	MAX.		
Α	0.70	0.75	0.80	0.028	0.030	0.031		
A1	0.00		0.05	0.000		0.002		
b	0.35	0.40	0.45	0.014	0.016	0.018		
b1	0.20	0.25	0.38	0.008	0.010	0.015		
С	0.18	0.20	0.23	0.007	0.008	0.009		
D	2.90	3.00	3.10	0.114	0.118	0.122		
D2	2.35	2.40	2.45	0.093	0.094	0.096		
Е	2.90	3.00	3.10	0.114	0.118	0.122		
E1	0.94	0.99	1.04	0.037	0.039	0.041		
E2	0.47	0.52	0.57	0.019	0.020	0.022		
е		0.65 BSC			0.026 BSC			
K	0.25 typ.			0.010 typ.				
K1	0.35 typ.			0.014 typ.				
K2	0.30 typ.			0.012 typ.				
I	0.27	0.32	0.37	0.011	0.013	0.015		

DWG: 5998



### RECOMMENDED MINIMUM PAD FOR PowerPAIR® 3 x 3



Recommended PAD for PowerPAIR 3 x 3

Dimensions in millimeters (inches)

Keep-Out 3.5 mm x 3.5 mm for non terminating traces



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